Date Searched: 5/23/2006

Databases Searched: USPAT, USPGPUB

Plurals: ON Terms Searched:

L1 (programmable adj3 (device or array)) or fpga or pga or pld or cpld

L2 (gate near5 leak\$4)

L3 (power or current or voltage) same (consumption or dissipat\$4 or consum\$2 or leak\$4)

L4 2 same 3 L5 1 and 4 Results: 385 hits

L6 716/1-18.ccls. and 5 and @pd>20060322

Results: 1 hit

L7 5 and 713/1,2,100.ccls.

Results: 0 hit

US 20060095872 A1

US-PGPUB

McElvain; Kenneth S. et al.

716/1

Interference Search

Database Searched: USPGPUB

Plurals: ON Terms Searched:

L1 (((programmable adj3 (device or array)) or fpga or pga or pld or cpld) and (gate near5 leak\$4) and (power or current or voltage) same (consumption or dissipat\$4 or consum\$2 or leak \$4) and stack\$3).clm.

Results: 0 hit

results. U fill

Date Searched: 3/22/2006

Databases Searched: USPAT, USPGPUB

Plurals: ON Terms Searched:

L1 (programmable adj3 (device or array)) or fpga or pga or pld or cpld

L2 (gate near5 leak\$4)

L3 (power or current or voltage) same (consumption or dissipat\$4 or consum\$2 or leak\$4)

L4 2 same 3 L5 1 and 4 Results: 385 hits

L6 716/1-18.ccls. and 5 and @pd>20060218

Results: 0 hit

Date Searched: 2/18/2006

Databases Searched: USPAT, USPGPUB

Plurals: ON Terms Searched:

L1 (programmable adj3 (device or array)) or fpga or pga or pld or cpld

L2 (gate near5 leak\$4)

L3 (power or current or voltage) same (consumption or dissipat\$4 or consum\$2 or leak\$4)

L4 2 same 3 L5 1 and 4 Results: 385 hits

L6 716/1-18.ccls. and 5 and @pd>20051223

Results: 1 hit

US 6993737 B1

USPAT Anderson; Jason H. et al.

716/5

Date Searched: 12/23/2005

Databases Searched: USPAT, USPGPUB

Plurals: ON Terms Searched: L1 (programmable adj3 (device or array)) or fpga or pga or pld or cpld L2 (gate near5 leak\$4) L3 (power or current or voltage) same (consumption or dissipat\$4 or consum\$2 or leak\$4) L4 2 same 3 L5 1 and 4 Results: 385 hits 716/1-18.ccls. and 5 Results: 6 hits **L7** (power or current or voltage) near5 (dissipat\$4 or leak\$4) 1 and 7 and 716/1-18.ccls. L8 Results: 169 hits (gate or gated or gating) same 7 L9 L10 8 and 9 Results: 65 hits stack\$3 near3 transistor L11 L12 10 and 11 Results: 0 hit (statistic\$2 or probability or likelihood or likely) same (low or high or on or off or active or L13 inactive or enable\$1 or disable\$1) L14 13 same 7 1 and 9 and 14 L15 Results: 35 hits 1 and 9 and 11 L16 Results: 110 hits L17 16 and 716/1-18.ccls. Results: 0 hit (statistic\$2 or probability or likelihood or likely) same stack\$3 L18 1 and 9 and 18 L19 Results: 22 hits L20 1 and (9 same 11) Results: 3 hits US 20040216074 A1 **US-PGPUB** Hart. Michael J. et al. 716/16 USPAT Dangelo; Carlos et al. 716/18 US 6324678 B1 US 6038386 A USPAT Jain; Gitu 716/16 US 5712790 A USPAT Ditlow; Gary Stephen et al. 716/2 US 6345379 B1 USPAT Khouja; Adel et al. US 20050091629 A1 **US-PGPUB** Eisenstadt, Robert et al.716/13 US 6075932 A USPAT Khouja; Adel et al. 716/4 US 20050097496 A1 **US-PGPUB** Koike, Hanpei et al. 716/13 US 20040025135 A1 **US-PGPUB** Hart, Michael J. et al. 716/16 US 6777978 B2 USPAT Hart: Michael J. et al. 326/38 US 6681376 B1 USPAT Balasinski; Artur et al. 716/4 USPAT Dave; Bharat P. et al. 716/1 US 6289488 B1 USPAT Dave: Bharat P.716/7 US 6230303 B1 US 6562638 B1 USPAT Balasinski; Artur et al. 438/14 US 20050198606 A1 US-PGPUB Gupta, Sanjay et al. 716/18 US 20050071800 A1 **US-PGPUB** Liu, Ming-Kang 716/18

US-PGPUB

US-PGPUB

Killian, Earl A. et al.

Sokolov, Serguei A.

716/18

716/4

US 20040250231 A1

US 20030208733 A1

US 6871172 B1 USPAT Sanders; Lester 703/14

US 6480815 B1 USPAT Olson; Janet et al. 703/14

US 6195630 B1 USPAT Mauskar; Ashutosh S. et al. 703/18

US 5949689 A USPAT Olson; Janet et al. 703/14 US 5508939 A USPAT Kim; Jaeseok et al. 716/7

Stacked transistors

US 5694055 A USPAT Shimanek; Schuyler E. 326/37

US 6868014 B1 USPAT Melik-Martirosian; Ashot et al. 365/185.28

Databases Searched: EPO, JPO, IBM TDB, Derwent

Plurals: ON Terms Searched:

L1 (programmable adj3 (device or array)) or fpga or pga or pld or cpld

L2 (power or current or voltage) near5 (dissipat\$4 or leak\$4)

L3 (gate or gated or gating) same 2

L4 1 and 3 Results: 31 hits

L5 stack\$3 near3 transistor

L6 4 and 5 Results: 1 hit

L7 (statistic\$2 or probability or likelihood or likely) same stack\$3

L8 1 and 3 and 7

Results: 1 hit

L9 (statistic\$2 or probability or likelihood or likely) same (low or high or on or off or active or

inactive or enable\$1 or disable\$1)

L10 1 and 3 and 9 Results: hits

EP 416903 A2 A2, A3 EPO WHITTEN, RALPH G et al.

NN9603163 IBM_TDB NN8803247 IBM_TDB

US 6871172 B DERWENT SANDERS, L

US 6768338 B DERWENT KONDAPALLI, V M et al.

US 5576636 A DERWENT BAUCOM, T L EP 667679 A A1, B1 DERWENT HANWOOD, M G

NN940169 IBM_TDB

Database Searched: IEE/IEEE XPlore

Terms Searched: ((programmable <near/3> (device or array)) or fpga or pga or pld or

cpld) and

((power or current or voltage) <near/5> (dissipat* or leak*)) and (gate or gated or gating)

Results: Your search matched 89 of 1286976 documents.

Terms Searched: ((programmable <near/3> (device or array)) or fpga or pga or pld or cpld) and

((power or current or voltage) <near/5> (dissipat* or leak*)) and (gate or gated or gating) and (stack* <near/5> transistor)

Results: Your search matched 1 of 1286976 documents.

Terms Searched: ((programmable <near/3> (device or array)) or fpga or pga or pld or cpld) and

((power or current or voltage) <near/5> (dissipat* or leak*)) and (statistic* or probability or likelihood or likely) and stack*

Results: Your search matched 0 documents.

Terms Searched: ((programmable <near/3> (device or array)) or fpga or pga or pld or cpld) and

((power or current or voltage) <near/5> (dissipat* or leak*)) and ((statistic* or probability or likelihood or likely) <near/15> (low or high or on or off or active or inactive or enable* or disable*))

Results: Your search matched 4 of 1286976 documents.